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TEXAS INSTRUMENTS

TSC2008

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SBAS406-JUNE 2008

# 1.2V to 3.6V, 12-Bit, Nanopower, 4-Wire Micro TOUCH SCREEN CONTROLLER with SPI™

### **FEATURES**

- 4-Wire Touch Screen Interface
- Single 1.2V to 3.6V Supply/Reference
- Ratiometric Conversion
- Effective Throughput Rate:
- Up to 20kHz (8 Bit) or 10kHz (12 Bit)
- Preprocessing to Reduce Bus Activity
- SPI Interface
- Simple, Command-Based User Interface:
  - TSC2046 Compatible
  - 8- or 12-Bit Resolution
- On-Chip Temperature Measurement
- Touch Pressure Measurement
- Digital Buffered PENIRQ
- On-Chip, Programmable PENIRQ Pullup
- Auto Power-Down Control
- Low Power:
  - 32.4µA at 1.2V, Fast Mode, 8.2kHz Eq Rate
  - 43.8µA at 1.8V, Fast Mode, 8.2kHz Eq Rate
  - 58.4μA at 2.7V, Fast Mode, 8.2kHz Eq Rate
- Software Reset
- Enhanced ESD Protection:
  - ±8kV HBM
  - ±1kV CDM
  - Target ±25kV Air Gap Discharge
  - Target ±15kV Contact Discharge
- 1.5 x 2 WCSP-12 and 4 x 4 QFN-16 Packages

U.S. Patent No. 6246394; other patents pending.

### APPLICATIONS

- Cellular Phones
- PDA, GPS, and Media Players
- Portable Instruments
- Point-of-Sale Terminals
- Multiscreen Touch Control

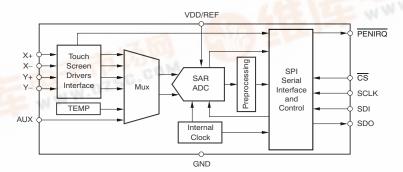
### DESCRIPTION

The TSC2008 is a very low-power touch screen controller designed to work with power-sensitive, handheld applications that are based on advanced low-voltage processors. It works with a supply voltage as low as 1.2V, which can be supplied by a single-cell battery. It contains a complete, ultra-low power, 12-bit, analog-to-digital (A/D) resistive touch screen converter, including drivers and the control logic to measure touch pressure.

In addition to these standard features, the TSC2008 offers preprocessing of the touch screen measurements to reduce bus loading, thus reducing the consumption of host processor resources that can then be redirected to more critical functions.

The TSC2008 supports an SPI serial bus and data transmission protocol in all three defined modes: standard, fast, and high-speed. It offers programmable resolution of 8 or 12 bits to accommodate different screen sizes and performance needs.

The TSC2008 is available in a 12-lead, (1,555  $\pm$ 0,055mm) x (2,055  $\pm$ 0,055mm) 3 x 4 array, wafer chip-scale package (WCSP), and a 16-pin, 4 x 4 QFN package. The TSC2008 is characterized for the -40°C to +85°C industrial temperature range.



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PRODUCT PREVIEW information concerns products in the formative or design phase of development. Characteristic data and



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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### **ORDERING INFORMATION**<sup>(1)</sup>

PRODUCT	TYPICAL INTEGRAL LINEARITY (LSB)	TYPICAL GAIN ERROR (LSB)	NO MISSING CODES RESOLUTION (BITS)	PACKAGE TYPE	PACKAGE DESIGNATOR	SPECIFIED TEMPERATURE RANGE	PACKAGE MARKING	ORDERING NUMBER	TRANSPORT MEDIA, QUANTITY
TSC2008I	±1.5	-0.2/+4.4	11	16-Pin, 4 x 4 QFN	RGV	-40°C to +85°C	TSC2008I	TSC2008RGVT	Small Tape and Reel, 250
								TSC2008RGVR	Tape and Reel, 25000
				12-Pin, 3 x 4 Matrix, 1.5 x 2 WCSP	YZG	-40°C to +85°C	TSC2008I	TSC2008IYZGT	Small Tape and Reel, 250
								TSC2008IYZGR	Tape and Reel, 3000

(1) For the most current package and ordering information, see the Package Option Addendum located at the end of this data sheet, or see the TI website at www.ti.com.

#### ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

Over operating free-air temperature range (unless otherwise noted).

	TSC2008	UNIT		
	Analog input X+	, Y+, AUX to GND	-0.4 to VDD + 0.1	V
Voltage	Analog input X-	, Y– to GND	-0.4 to VDD + 0.1	V
Voltage range	VDD to GND		-0.3 to +5	V
Digital input voltage to GND	-0.3 to VDD + 0.3	V		
Digital output voltage to GND	-0.3 to VDD + 0.3	V		
Power dissipation	(T <sub>J</sub> Max - T <sub>A</sub> )/θ <sub>JA</sub>			
	QFN package		47	°C/W
Thermal impedance, $\theta_{JA}$	14/005	Low-K	113	°C/W
	WCSP	High-K	62	°C/W
Operating free-air temperature range	e, T <sub>A</sub>	L.	-40 to +85	°C
Storage temperature range, T <sub>STG</sub>	-65 to +150	°C		
Junction temperature, T <sub>J</sub> Max	+150	°C		
	Vapor phase (6	0 sec)	+215	°C
Lead temperature	Infrared (15 sec	)	+220	°C

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated is not implied. Exposure to absolute-maximum rated conditions for extended periods may affect device reliability.

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### **ELECTRICAL CHARACTERISTICS**

At  $T_A = -40^{\circ}$ C to +85°C,  $V_{DD} = +1.2$ V to +3.6V, unless otherwise noted.

					TSC2008			
PARAMETER			TEST CONDITIONS	MIN TYP MAX			UNIT	
AUXILIARY ANA	ALOG INPUT					·		
Input voltage ran	nge			0		V <sub>DD</sub>	V	
Input capacitance	e				12		pF	
Input leakage cu	irrent			-1		+1	μΑ	
A/D CONVERTE	ER							
Resolution		Programmable	: 8 or 12 bits			12	Bits	
No missing code	es	12-bit resolution	n	11			Bits	
Integral linearity					±1.5		LSB <sup>(1)</sup>	
Offset error		$V_{DD} = 1.8V$		-0.8 to +0.3			LSB	
Oliset elloi		$V_{DD} = 3.0 V$		+3.2 to +8.9			LSB	
		$V_{DD} = 1.8V$			-0.2 to 0		LSB	
Gain error		$V_{DD} = 3.0 V$		+	-3.8 to +4.4		LSB	
TOUCH SENSO	RS							
PENIRQ pull-up	register P	$T_A = +25^{\circ}C, V_D$	<sub>D</sub> = 1.8V, command '1011' set '0000'		51		kΩ	
	Tesision, R <sub>IRQ</sub>	$T_A = +25^{\circ}C, V_D$	<sub>D</sub> = 1.8V, command '1011' set '0001'		90		kΩ	
Switch	Y+, X+				6		Ω	
on-resistance Y-, X-					5		Ω	
Switch drivers drive current <sup>(2)</sup>		100ms duration	1			50	mA	
INTERNAL TEM	IPERATURE SEN	SOR				·		
Temperature ran	nge			-40		+85	°C	
		Differential	$V_{DD} = 3V$			°C/LSE		
Pagalution		method <sup>(3)</sup>	V <sub>DD</sub> = 1.6V		1.6		°C/LSE	
Resolution		TEMP1 <sup>(4)</sup>	$V_{DD} = 3V$		0.3		°C/LSE	
			V <sub>DD</sub> = 1.6V		0.3		°C/LSE	
		Differential	$V_{DD} = 3V$	±2			°C/LSE	
A		method <sup>(3)</sup>	V <sub>DD</sub> = 1.6V	±2			°C/LSE	
Accuracy		TEMP1 <sup>(4)</sup>	$V_{DD} = 3V$		±3		°C/LSE	
		TEMPT	V <sub>DD</sub> = 1.6V			°C/LSE		
INTERNAL OSC	ILLATOR					·		
			V <sub>DD</sub> = 1.2V		3.19		MHz	
		0.04	V <sub>DD</sub> = 1.8V		3.66		MHz	
Internal clock frequency, f <sub>CCLK</sub>		8-Bit	V <sub>DD</sub> = 2.7V		3.78		MHz	
			V <sub>DD</sub> = 3.6V	3			MHz	
			V <sub>DD</sub> = 1.2V		1.6		MHz	
		10 D <sup>24</sup>	V <sub>DD</sub> = 1.8V		1.83		MHz	
		12-Bit	V <sub>DD</sub> = 2.7V	1.88			MHz	
			V <sub>DD</sub> = 3.6V	1.91			MHz	
<b>-</b>		V <sub>DD</sub> = 1.6V	·		0.0056		%/°C	
Frequency drift		$V_{DD} = 3.0V$			0.012		%/°C	

 LSB means *least significant bit.* With V<sub>DD</sub> (REF) = +2.5V, 1LSB is 610μV.
Assured by design, but not production tested. Exceeding 50mA source current may result in device degradation.
Difference between TEMP1 and TEMP2 measurement; no calibration necessary. (2) (3) (4)

Temperature drift is -2.1mV/°C.

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### **ELECTRICAL CHARACTERISTICS (continued)**

At  $T_A = -40^{\circ}$ C to +85°C,  $V_{DD} = +1.2$ V to +3.6V, unless otherwise noted.

						TSC2008			
PARAMETER			TEST CONDITIO	ONS	MIN	TYP	MAX	UNIT	
DIGITAL INP	JT/OUTPUT								
Logic family					CMOS				
		$1.2 \text{V} \leq \text{V}_{\text{DD}} < 1.6$	V		$0.7 \times V_{DD}$		V <sub>DD</sub> + 0.3	V	
	V <sub>IH</sub>	$1.6V \le V_{DD} \le 3.6$	V		$0.7 \times V_{DD}$		V <sub>DD</sub> + 0.3	V	
		$1.2 \text{V} \leq \text{V}_{\text{DD}} < 1.6$	V		-0.3		$0.2 \times V_{DD}$	V	
	VIL	$1.6V \le V_{DD} \le 3.6$	V		-0.3		$0.3 \times V_{DD}$	V	
	IIL	CS, SCLK, and S	SDI pins		-1		1	μΑ	
Logic level	C <sub>IN</sub>	CS, SCLK, and S	SDI pins				10	pF	
	V <sub>OH</sub>	I <sub>OH</sub> = 2 TTL load	s		V <sub>DD</sub> - 0.2		V <sub>DD</sub>	V	
	V <sub>OL</sub>	I <sub>OL</sub> = 2 TTL loads	6		0		0.2	V	
	I <sub>LEAK</sub>	Floating output			-1		1	μΑ	
	C <sub>OUT</sub>	Floating output					10	pF	
Data format					Straight Binary				
POWER SUP	PLY REQUIREMEN	NTS							
Power-supply	voltage								
V <sub>DD</sub>		Specified perform	Specified performance		1.2		3.6	V	
			1 2)/	36.4k eq rate		128	190	μΑ	
Quiescent supply current $(V_{DD}$ with sensor off)		12-bit	$V_{DD} = 1.2V$	8.2k eq rate		32.4	48	μΑ	
		f <sub>SCLK</sub> = 10MHz,	N/ 4 0V/	36.4k eq rate		165	240	μΑ	
		$f_{ADC} = 1MHz,$ PD[1:0] = 0,0	V <sub>DD</sub> = 1.8V	8.2k eq rate		43.8	60	μΑ	
		FD[1.0] = 0,0	V 0.7V	36.4k eq rate		226.2	335	μΑ	
			$V_{DD} = 2.7V$	8.2k eq rate		63.4	84	μA	
Power-down s	supply current	CS = 1, SDI = S	CLK = 1, PD[1:0] =	= 0,0		0	0.8	μΑ	

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23-Jun-2008

#### PACKAGING INFORMATION

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
TSC2008IRGVR	PREVIEW	QFN	RGV	16	2500	TBD	Call TI	Call TI
TSC2008IRGVT	PREVIEW	QFN	RGV	16	250	TBD	Call TI	Call TI
TSC2008IYZGR	PREVIEW	DSBGA	YZG	12	3000	TBD	Call TI	Call TI
TSC2008IYZGT	PREVIEW	DSBGA	YZG	12	250	TBD	Call TI	Call TI

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

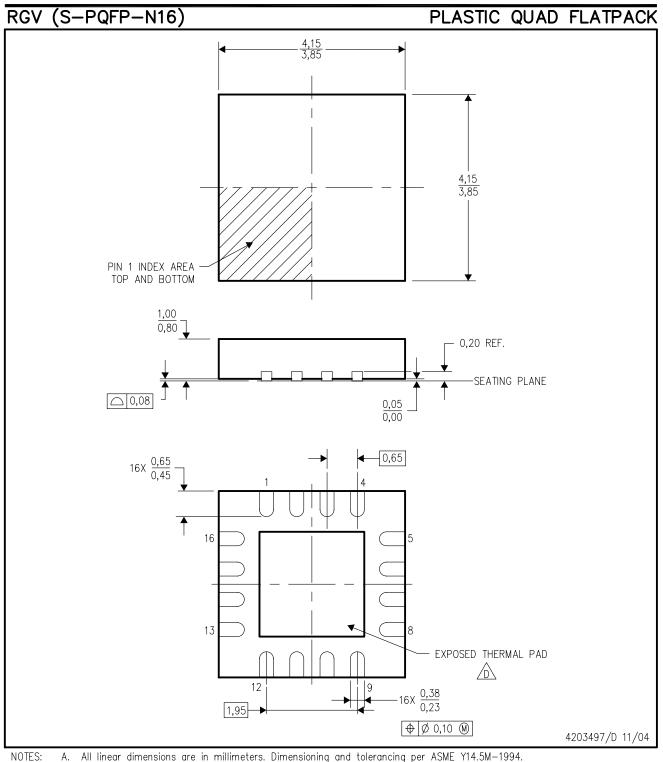
Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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### **MECHANICAL DATA**



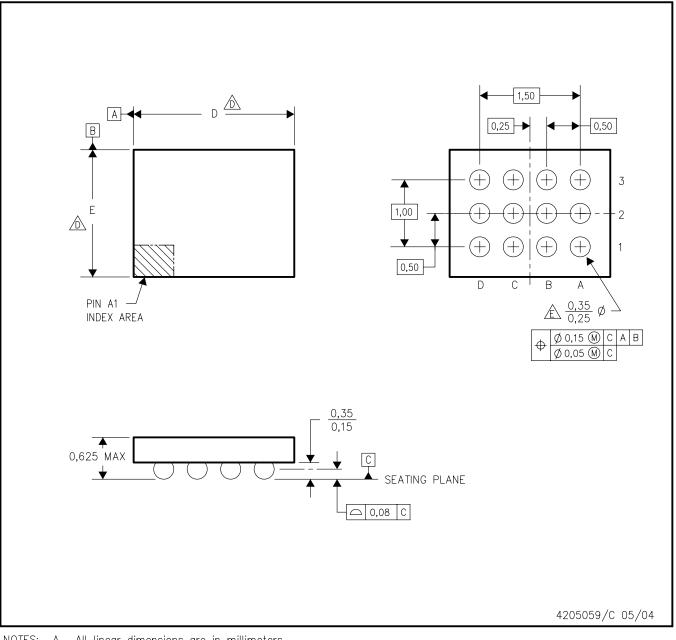
All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994. Α.

- B. This drawing is subject to change without notice.
- C. Quad Flatpack, No-leads (QFN) package configuration.
- ⚠ The package thermal pad must be soldered to the board for thermal and mechanical performance. See the Product Data Sheet for details regarding the exposed thermal pad dimensions.
- E. Falls within JEDEC MO-220.



# YZG (R-XBGA-N12)

## DIE-SIZE BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. NanoFree™ package configuration.
- Devices in YZG package can have dimension D ranging from 1.85 to 2.65 mm and dimension E ranging from 1.35 to 2.15 mm. To determine the exact package size of a particular device, refer to the device datasheet or contact a local TI representative.

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- Reference Product Data Sheet for array population. 4 x 3 matrix pattern is shown for illustration only.
- F. This package contains lead-free balls. Refer to YEG (Drawing #4204182) for tin-lead (SnPb) balls.

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